Confidential

# APPROVAL SHEET

| Customer Name     | : |                     |
|-------------------|---|---------------------|
| Customer P/N      | : |                     |
| Frequency         | : | 30.000000 MHz       |
| Aker Approved P/N |   | SMBN-030000-7-D4-00 |
| Aker MPN          |   | SMBN-030000-7-D4-00 |
| Rev.              |   | 1                   |
| ISSUE DATE        |   | Feb.13.2023         |

| APPROVED         | CHECKED | PREPARED |
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| (in              |         | Xīn      |
| APPROVED BY CUST | OMER    |          |
|                  |         |          |

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MSL:Level 1 RoHS compliant



| Aker Approved F | P/N : | SMBN- | -030000-7-D4-00 |
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| APPROVED        | •     | Tin   | SHEET : 1 of 10 |
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| Rev. | Date      | Reviser | Revise contents  |
|------|-----------|---------|------------------|
| 1    | 2023/2/13 | Xin     | Initial Released |
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| Aker Approved I | P/N : | SMBN | -030000-7-D4-00 |
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# SMD CRYSTAL OSCILLATOR

### **1. ELECTRICAL CHARACTERISTICS**

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement

and tests are as follow :

Ambient temperature :  $25\pm5$  °C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : 25±3 °C

Relative humidity : 40%~70%

■ AKER Model : SMBN-751

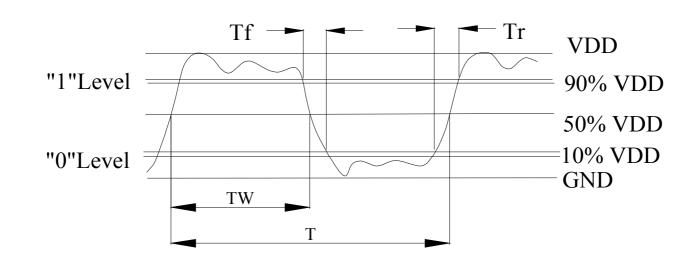
• Cutting Mode : AT CUT

|                           |        | Electrical Spec |         |        |        |                  |
|---------------------------|--------|-----------------|---------|--------|--------|------------------|
| Parameters                | Symbol | Min.            | Тур.    | Max.   | Units. | Notes            |
| Nominal Frequency         |        | 3               | 0.00000 | 0      | MHz    |                  |
| Frequency Stability       |        |                 | ±100    |        | ppm    |                  |
| Supply Voltage            | Vcc    | 1.62            | ~       | 3.63   | V      |                  |
| Output Load CMOS          | CL     |                 |         | 15     | pF     |                  |
| Aging                     |        |                 | ±3      |        | ppm    | First Year       |
| Enable Control            |        |                 | Yes     |        |        | Pad 1            |
| Operating Temperature     |        | -40             | 25      | 85     | °C     |                  |
| Storage Temperature Range |        | -55             | ~       | 125    | °C     |                  |
| Output Voltage High       | VoH    | 90%Vdd          |         |        | V      |                  |
| Output Voltage Low        | VoL    |                 |         | 10%Vdd | V      |                  |
| Input Current             | Icc    |                 |         | 12     | mA     |                  |
| Standby Current           | Ist    |                 |         | 10     | μA     |                  |
| Rise Time                 | Tr     |                 |         | 10     | ns     | 10%~90%VDD Level |
| Fall Time                 | Tf     |                 |         | 10     | ns     | 90%~10%VDD Level |
| Symmetry (Duty ratio)     | TH/T   | 45              | ~       | 55     | %      |                  |
| Start-up Time             | Tosc   |                 |         | 10     | ms     |                  |
| Enable Voltage High       | Vhi    | 70%Vdd          |         |        | V      |                  |
| Disable Voltage Low       | Vlo    |                 |         | 30%VDD | V      |                  |
| Output Enable Delay Time  | T on   |                 |         | 10     | ms     |                  |
| Output Disable Delay Time | T off  |                 |         | 200    | ns     |                  |
| Phase Jitter RMS          |        |                 |         | 1      | ps     | 12KHz~5MHz       |

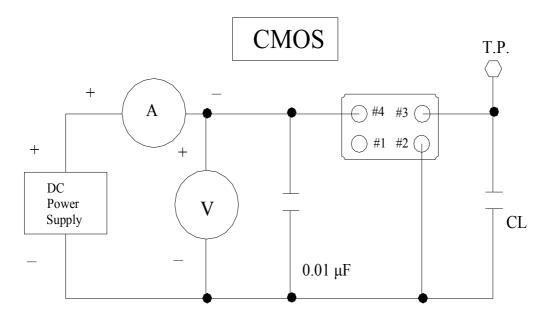


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|                   |     |        |                 |  |  |  |  |

# 2. C - MOS LOAD OUTPUT WAVEFORM



# **3.C-MOS LOAD TEST CIRCUIT**

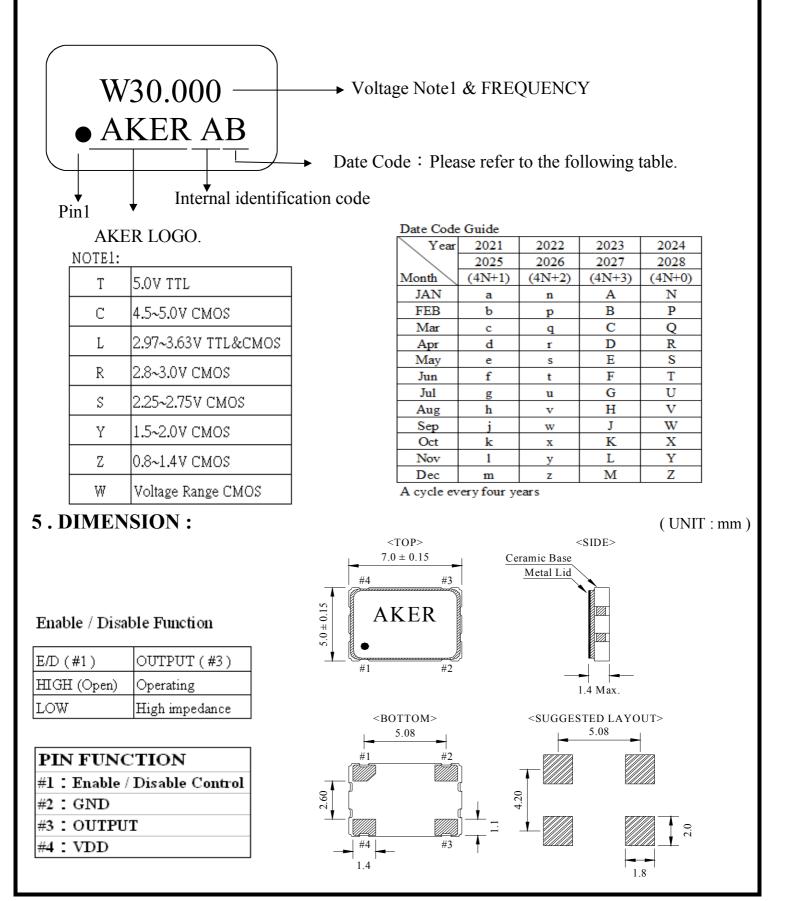


\*\*\*Because SMA series has no by pass capacitor. So,we recommend our customer to use capacitor  $0.01 \ \mu F$  in join Vcc and GND.



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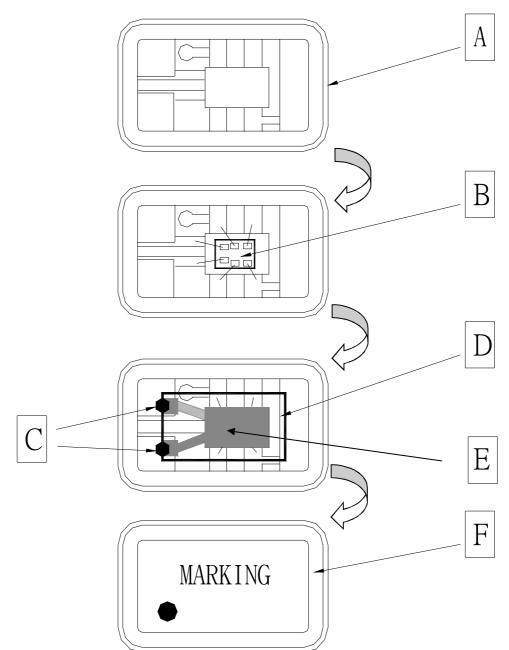
## 4. MARKING :





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# **6** . STRUCTURE ILLUSTRATION

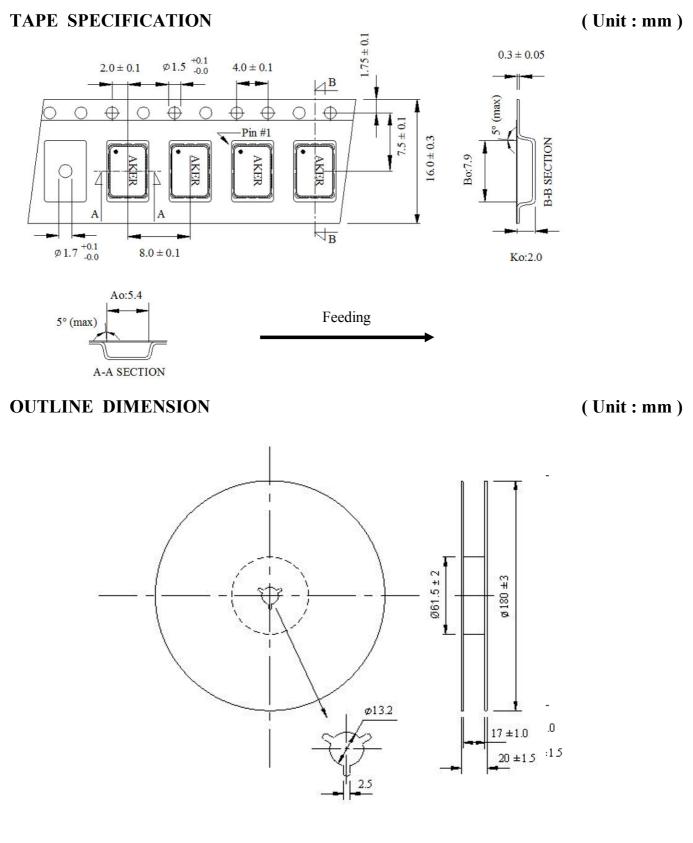


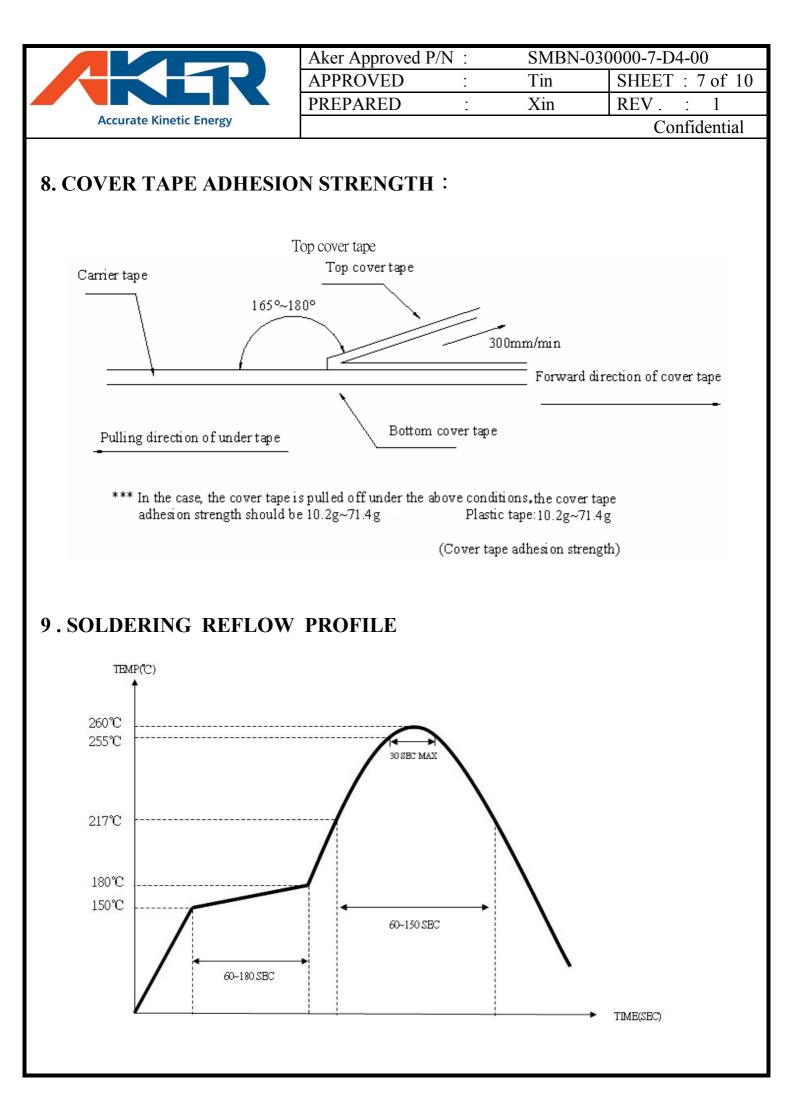
|   | COMPONENTS          | MATERIALS                        | CO | MPONENTS      | MATERIALS |
|---|---------------------|----------------------------------|----|---------------|-----------|
| A | Base (Package)      | Ceramic (Al2O3)+Kovar (Fe/Co/Ni) | D  | Crystal blank | SiO2      |
| В | IC chip             |                                  | E  | Electrode     | Cr / Ag   |
| С | Conductive adhesive | Ag / Silicon resin               | F  | Lid           | Fe/Co/Ni  |

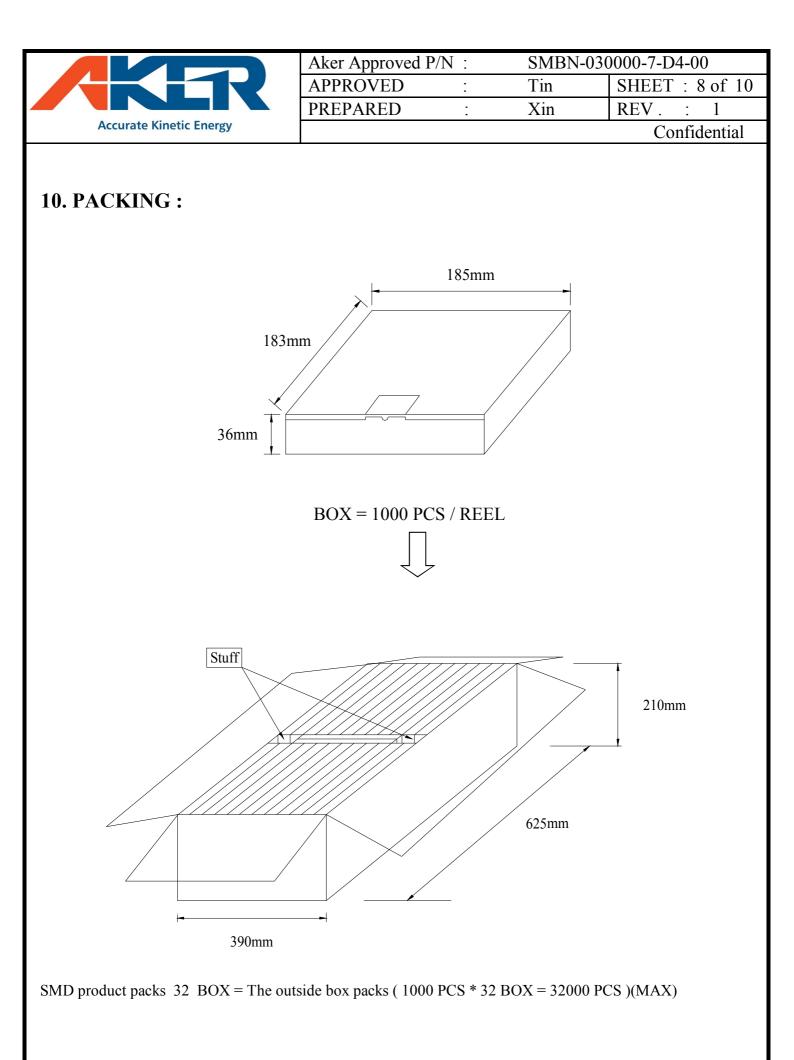


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# 7. PACKING :









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# **11. MECHANICAL PERFORMANCE**

| TEST ITEMS          | TEST METHODS AND TEST CONDITION   | PERFORMANCE                             |  |
|---------------------|---|---|--|
| 11.1 Drop Test      | The specimen is measured for its frequency<br>before the test. It is then dropped from<br>a hight of 75 cm or more as a free fall object onto<br>a hard wooden plate of 30mm or more in thickness.<br>( in accordance with JIS-C0044 )  | To satisfy the electrical performance . |  |
| 11.2 Vibration Test | The specimen is measured for its frequency<br>before the test. Most them into<br>X,Y and Z axes, respectively, for the vibration test.<br>Vibration condition:<br>Frequency range ; 20 ~ 2000HZ<br>Peak to peak amplitude : 1.52 mm<br>Peak acceleration : 20G<br>Sweep time : 20 minute / axis<br>Pendicular total test time : 4 hours |   |  |
| 112 Desistance to   | ( in accordance with MIL-STD-883F : 2007.3 )  |   |  |
| 11.3 Resistance to  | The specimen is measured for its frequency  |   |  |
| Soldering Test      | before the test. Place the specimen on<br>the belt of the convergence and let it pass through   |   |  |
|                     | the belt of the converynace and let it pass through   |   |  |
|                     | the reflow with the presetted temperature condition.  |   |  |
|                     | After passing twice the reflow place, the specimen under the referee condition for $-2$ hours and then  |   |  |
|                     |   |   |  |
|                     | measure its electrical performance.   |   |  |
|                     | Temperature Condition of IR Simulation:   |   |  |
|                     | The temperature range of the preheated section<br>is setted at $150 \approx 120^{\circ}$ for (0, 120 and For the next   |   |  |
|                     | is setted at 150 $\sim$ 180 °C for 60~120 sec. For the next   |   |  |
|                     | section the temperature range is setted at $217 \sim 260^{\circ}$ C   |   |  |
|                     | for 45~90 sec. and within this time range the specimen  |   |  |
|                     | should be able to sustain at the peak temperature,<br>$2(0+(2)^{\circ}) = (-1)^{\circ}$   |   |  |
|                     | $260+/-3^{\circ}$ °C, for 10 sec long.  |   |  |
| 11 4 Eine Leele     | ( in accordance with JESD22-B106-B )  |   |  |
| 11.4 Fine Leak      | Place the specimen in a pressurized container and   | Less than                               |  |
| Test                | pressurize it with the detection gas (mixed gas   | $1.0 * 10^{-8}$ atm .c.c. / sec,        |  |
|                     | consisting of 95% or more helium ) for at least 2 hours.  | Helium                                  |  |
|                     | Complete the measurement of the concentration of<br>helium within 30 min after taking it out from the   |   |  |
|                     | pressurized container.  |   |  |
|                     | ( in accordance with MIL-STD-883F : 1014.11 )   |   |  |
|                     | The referee condition .   | I                                       |  |
|                     |   |   |  |
|                     | Temperature $25 \pm 2$ °C<br>Humidity $44 \approx 55.9$   |   |  |
|                     | Humidity $44 \approx 55 \%$<br>Pressure $86 \approx 106 \text{ kPa}$  |   |  |
|                     | ( in accordance with MIL-STD-883E : 1014.9 )  |   |  |



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# **12. CLIMATIC RESISTANCE**

| TEST ITEMS                                 | TEST METHODS AND TEST CONDITION   | PERFORMANCE                             |
|--|---|---|
| 12.1 Low Temp<br>Exposure Test             | The specimen is measured for its frequency<br>before the test .<br>Place the specimen in the chamber and kept it<br>at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours .<br>Take the specimen out of the chamber<br>and measure itselectrical performance after<br>leaving 1 ~ 2 hours under the referee condition.<br>( in accordance with JIS-C0020 )  |   |
| 12.2 Aging Test                            | The specimen is measured for its frequency<br>before the test .<br>Place the specimen in the testing chamber and keep it<br>at the temperature of $+ 125 \pm 3^{\circ}$ C for 720 $\pm 48$ hours.<br>And then take the specimen out of the chamber and<br>measure its electrical performance after leaving<br>for 1 ~ 2 hours under the referee condition .<br>( in accordance with JIS-C0021 )   | To satisfy the electrical performance . |
| 12.3 High<br>Temperature &<br>High Humidty | The specimen is measured for its frequency<br>before the test .<br>Place the specimen in the testing chamber and<br>kept it at the temperature of $+85 \pm 5$ °C and<br>humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and<br>then take the specimen out and measure its<br>electrical performance after leaving for 1 ~ 2<br>hours under the referee condition.<br>( in accordance with MIL-STD-883F : 1004.7 )  |   |
| 12.4 Temperature<br>Cycle Test             | The specimen is measured for its frequency<br>before the test .<br>Subject the specimen to the 100 cycles of<br>temperature ranges stated below .<br>High temp . + $125 \pm 3 \degree C$ ( $15\pm 3 \min$ ).<br>$2\sim 3 \min$<br>$2\sim 3 \min$<br>Low temp $55 \pm 3 \degree C$ ( $15\pm 3 \min$ ).<br>Measure its electrical performance after leaving it<br>for 1 ~ 2 hours under the referee condition .<br>( in accordance with MIL-STD-883F : 1010.8 ) |   |